



CERTIFICATE OF ACCREDITATION

ANSI-ASQ National Accreditation Board

500 Montgomery Street, Suite 625, Alexandria, VA 22314, 877-344-3044

This is to certify that

Keysight Technologies, Inc. Service Center

900 South Taft Avenue

Loveland, CO 80537

has been assessed by ANAB
and meets the requirements of international standard

ISO/IEC 17025:2005

and national standard

ANSI/NCSL Z540-1-1994

& ANSI/NCSL Z540.3-2006

while demonstrating technical competence in the field(s) of

CALIBRATION

Refer to the accompanying Scope(s) of Accreditation for information regarding the types of calibrations to which this accreditation applies.

AC-1813

Certificate Number

ANAB Approval



Certificate Valid: 08/01/2014 - 10/07/2015
Version No. 001 Issued: 01/16/2015



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated January 2009).



ANSI-ASQ National Accreditation Board

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005, ANSI/NCSL Z540-1-1994, & ANSI/NCSL Z540.3-2006

Keysight Technologies, Inc. Service Center

www.keysight.com

900 South Taft Avenue Loveland, CO 80537

Point of Contact: Ron Eastwood Email: ron_eastwood@keysight.com Phone: 916-788-5506

CALIBRATION

Valid to: October 7, 2015

Certificate Number: AC - 1813

I. Electromagnetic - DC/Low Frequency

PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
DC Voltage - Source	150 μ V to 10 V	0.01 μ V/V + 100 nV	Josephson Junction	Agilent/OEM Procedures
	0.1 V	0.67 μ V/V	Fluke 732	
	1 V	0.23 μ V/V	Fixed Oil Resistors	
	10 V	0.14 μ V/V		
	100 V	0.53 μ V/V		
DC Voltage - Measure	100 mV	0.67 μ V/V	Fixed Oil Resistors Josephson Junction	Agilent/OEM Procedures
	1 V	0.23 μ V/V		
	10 V	0.14 μ V/V		
	100 V	0.53 μ V/V		
	1 kV	1.3 μ V/V		
DC Current - Source	100 nA	12 μ A/A	Fixed Resistors in Oil HP 3458A	Agilent/OEM Procedures
	1 μ A	5.2 μ A/A		
	10 μ A	5.1 μ A/A		
	100 μ A	1 μ A/A		
	1 mA	1.0 μ A/A		
	10 mA	1.0 μ A/A		
	100 mA	1.0 μ A/A		
	1 A	1.7 μ A/A		



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
AC Voltage - Source	10 mV			
	1 kHz	31 µV/V		
	20 kHz	95 µV/V		
	100 kHz	0.16 mV/V		
	300 kHz	0.29 mV/V		
	1 MHz	0.90 mV/V		
	4 MHz	2.4 mV/V		
	100 mV			
	1 kHz	26 µV/V		
	20 kHz	31 µV/V		
	100 kHz	68 µV/V		
	300 kHz	0.12 mV/V		
	1 MHz	0.51 mV/V		
	4 MHz	2.3 mV/V		
	8 MHz	3.6 mV/V		
	10 MHz	4.3 mV/V		
	1 V			
	1 kHz	15 µV/V		
	20 kHz	17 µV/V		
	50 kHz	20 µV/V		
100 kHz	21 µV/V			
300 kHz	38 µV/V			
500 kHz	73 µV/V			
1 MHz	0.25 mV/V			
4 MHz	2.3 mV/V			
8 MHz	3.6 mV/V			
10 MHz	4.4 mV/V			
3 V				
100 kHz	23 µV/V			
2 MHz	2.3 mV/V			
4 MHz	2.3 mV/V			
8 MHz	3.6 mV/V			
10 MHz	4.3 mV/V			

Datron 4700
HP 33250A
Fluke 5790A

Agilent/OEM
Procedures



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
AC Voltage - Source (cont.)	10 V 10 Hz 20 Hz 40 Hz 1 kHz 4 kHz 8 kHz 10 kHz 20 kHz 50 kHz 100 kHz 300 kHz 500 kHz 1 MHz 100 V 1 kHz 20 kHz 50 kHz 100 kHz 700 V 1 kHz 20 kHz 1 kV 1 kHz 10 kHz 20 kHz	34 μV/V 26 μV/V 23 μV/V 15 μV/V 15 μV/V 15 μV/V 15 μV/V 15 μV/V 23 μV/V 23 μV/V 49 μV/V 86 μV/V 0.29 mV/V 18 μV/V 19 μV/V 24 μV/V 33 μV/V 21 μV/V 26 μV/V 41 μV/V 58 μV/V 62 μV/V	Datron 4700 HP 33250A Fluke 5790A	Agilent/OEM Procedures
AC Voltage - Measure	1 mV (10 to 20) Hz 20 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 3 mV (10 to 20) Hz 20 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz	0.46 mV/V 0.43 mV/V 0.54 mV/V 0.67 mV/V 1.8 mV/V 2.8 mV/V 4.5 mV/V 0.10 mV/V 80 μV/V 0.12 mV/V 0.21 mV/V 0.42 mV/V 0.94 mV/V 1.9 mV/V	Fluke 5790A	



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
AC Voltage - Measure (cont.)	10 mV (10 to 20) Hz (20 to 100) Hz 100 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 30 mV (10 to 20) Hz 20 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 100 mV (10 to 20) Hz 20 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 300 mV (10 to 20) Hz 20 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 1 V (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (300 to 500) kHz 500 kHz to 1 MHz 3 V (1 to 100) kHz	56 µV/V 46 µV/V 44 µV/V 98 µV/V 0.17 mV/V 0.38 mV/V 0.58 mV/V 1.1 mV/V 55 µV/V 43 µV/V 44 µV/V 85 µV/V 0.14 mV/V 0.31 mV/V 0.71 mV/V 45 µV/V 33 µV/V 34 µV/V 74 µV/V 0.12 mV/V 0.27 mV/V 0.60 mV/V 33 µV/V 26 µV/V 23 µV/V 30 µV/V 52 µV/V 93 µV/V 0.19 mV/V 29 µV/V 23 µV/V 16 µV/V 15 µV/V 17 µV/V 30 µV/V 51 µV/V 0.16 mV/V 16 µV/V	Fluke 5790A	Agilent/OEM Procedures



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)	
AC Voltage - Measure (cont.)	6 V				
	1 kHz	18 µV/V			
	10 V				
	(10 to 20) Hz	28 µV/V			
	(20 to 100) Hz	23 µV/V			
	100 Hz to 1 kHz	13 µV/V			
	(1 to 20) kHz	14 µV/V			
	(20 to 100) kHz	17 µV/V			
	(100 to 300) kHz	40 µV/V			
	(300 to 500) kHz	65 µV/V			
	500 kHz to 1 MHz	0.19 mV/V			
	19 V				
	1 kHz	15 µV/V			
	100 V				
	(10 to 20) Hz	34 µV/V			
	(20 to 40) Hz	22 µV/V			
	40 Hz to 1 kHz	18 µV/V			
	(1 to 20) kHz	19 µV/V			
	(20 to 100) kHz	28 µV/V			
	(100 to 200) kHz	47 µV/V			
	300 V			Fluke 5790A	Agilent/OEM Procedures
	40 to 1 kHz	22 µV/V			
	(1 to 20) kHz	25 µV/V			
	(20 to 30) kHz	25 µV/V			
(30 to 50) kHz	39 µV/V				
(50 to 100) kHz	65 µV/V				
500 V					
40 to 1 kHz	20 µV/V				
(1 to 20) kHz	22 µV/V				
(20 to 30) kHz	26 µV/V				
(30 to 50) kHz	39 µV/V				
(50 to 100) kHz	77 µV/V				
700 V					
40 to 1 kHz	22 µV/V				
(1 to 20) kHz	33 µV/V				
(20 to 30) kHz	40 µV/V				
(30 to 50) kHz	54 µV/V				
(50 to 100) kHz	92 µV/V				
1 kV					
40 to 1 kHz	27 µV/V				
(1 to 20) kHz	25 µV/V				
(20 to 30) kHz	38 µV/V				



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
AC Voltage Wideband - Measure	Absolute Voltage (1 to 3) V 10 Hz to 500 kHz 500 kHz to 2 MHz (2 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.4 mV/V + 3 μV 0.41 mV/V + 1.4 μV 2 mV/V + 1.5 μV 2 mV/V + 3.9 μV 2.3 mV/V + 1.1 μV	Fluke 5790A	Agilent/OEM Procedures
	Voltage Flatness (1 to 3) mV 10 Hz to 120 kHz 120 kHz to 2 MHz (2 to 10) MHz (10 to 20) MHz (20 to 30) MHz (10 to 300) mV 10 Hz to 120 kHz 120 kHz to 2 MHz (2 to 10) MHz (10 to 20) MHz (20 to 30) MHz (1 to 3) V 10 Hz to 120 kHz 120 kHz to 2 MHz (2 to 10) MHz (10 to 20) MHz (20 to 30) MHz	0.20 mV/V 0.26 mV/V 0.9 mV/V 1.2 mV/V 1.4 mV/V 0.17 mV/V 0.24 mV/V 0.8 mV/V 1.2 mV/V 1.6 mV/V 0.12 mV/V 0.20 mV/V 0.5 mV/V 0.8 mV/V 1.1 mV/V		
AC Current - Source	40 Hz to 10 kHz 10 mA 50 mA 100 mA 0.5 A, 1 A 5 A 10 A 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	11 μA/A 13 μA/A 12 μA/A 17 μA/A 37 μA/A 53 μA/A 64 μA/A 73 μA/A	Fluke 5720A Holt HCS-1	

PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
AC Current - Measure	10 µA 10 Hz to 1 kHz (1 to 10) kHz 100 µA (10 to 20) Hz 20 Hz to 10 kHz (1 to 100) mA (10 to 20) Hz 20 Hz to 10 kHz 1 A (10 to 20) Hz 20 Hz to 10 kHz 10 A 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.11 mA/A 0.32 mA/A 88 µA/A 0.12 mA/A 76 µA/A 0.12 mA/A 0.11 mA/A 0.14 mA/A 0.15 mA/A 0.32 mA/A 0.43 mA/A	Fluke 5790A with Agilent ET22703 Shunt Box HP 3458A with 0.001 Ω Shunt	
Thermal Voltage Converters - Measure	(0.5 to 3) V 10 Hz 100 Hz 10, 30 kHz 100 kHz 300 kHz 1 MHz (3 to 10) V 10 Hz 1, 20 kHz 100 kHz 300 kHz 1 MHz (10 to 100) V 10 Hz 1, 20 kHz 100 kHz 200 kHz (100 to 700) V 40 Hz, 1kHz 20 kHz 100 kHz 1 000 V 40 Hz 1 kHz 10, 20 kHz 30 kHz	0.0016 % 0.0013 % 0.0007 % 0.0011 % 0.0022 % 0.0035 % 0.0013 % 0.0005 % 0.0008 % 0.0018 % 0.003 % 0.0014 % 0.0008 % 0.0011 % 0.0023 % 0.0012 % 0.0014 % 0.0029 % 0.0021 % 0.0014 % 0.0022 % 0.0024 %	Holt 11 TVC	Agilent/OEM Procedures

PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
Thermal Voltage Converters – Measure (cont.)	(0.5 to 3) V			
	(3, 8, 10) MHz (20, 30) MHz 50 MHz 70 MHz 80 MHz 100 MHz	0.12 % 0.25 % 0.62 % 0.93 % 1.1 % 1.3 %	Ballantine 1395A TVC	
Ratio Transformer – Magnitude Only	(1 to 100) V input, 1 kHz	0.52 parts in 10 ⁶ of input	ESI-DT72A Ratio Transformer	
Inductance (Series) - Measure	1 MHz			
	0.1 Ω 1 Ω 10 Ω 100 Ω	1.0 nH 0.30 nH 1.0 nH 7.0 nH	HP 4284A, 16074A	
Capacitance (Parallel)	1 MHz			
	100 Ω 1 kΩ 10 kΩ 100 kΩ	0.7 pF 0.07 pF 0.02 pF 0.004 pF	HP 4284A, 16074A, 16380A	
DC Resistance - Measure	1 mΩ	0.38 μΩ/Ω	Resistance Bridge Resistance Shunts in Oil, HP 3458A, 4339B	
	10 mΩ	0.38 μΩ/Ω		
	100 mΩ	0.38 μΩ/Ω		
	1 Ω	0.38 μΩ/Ω		
	10 Ω	0.44 μΩ/Ω		
	100 Ω	0.47 μΩ/Ω		
	1 kΩ	0.43 μΩ/Ω		
	10 kΩ	0.46 μΩ/Ω		
	100 kΩ	1.2 μΩ/Ω		
	1 MΩ	1.7 μΩ/Ω		
	10 MΩ	5.4 μΩ/Ω		
	100 MΩ	60 μΩ/Ω		
1 GΩ	0.19 mΩ/Ω			
10 GΩ	0.24 mΩ/Ω			
100 GΩ	0.21 mΩ/Ω			

PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
Capacitance - Measure	2/3 Terminal Pair - 1 kHz			
	1 pF to 40 nF	3 µF/F		
	(40 to 100) nF	4 µF/F		
	(100 to 400) nF	5 µF/F		
	400 nF to 1.2 µF	8 µF/F		
	Dissipation Factor - 1kHz			
	1 pF to 1 nF	0.000003		
	(1 to 10) nF	0.000005		
	(10 to 40) nF	0.00001		
	(40 to 70) nF	0.000015		
	(70 to 100) nF	0.00002		
	(100 to 200) nF	0.00004		
	(200 to 300) nF	0.000055		
	(300 to 400) nF	0.000075		
	(400 to 500) nF	0.000095		
	(500 to 600) nF	0.00011		
	(600 to 700) nF	0.000125		
	(700 to 800) nF	0.000145		
	(800 to 900) nF	0.00016		
	900 nF to 1 µF	0.000175		
	(1 to 1.1) µF	0.000195		
	(1.1 to 1.2) µF	0.00021		
	4 Terminal Pair			
	Dissipation Factor			
	1 pF			
	0.00002, 1 kHz	44 µF/F		
	0.00003, 1 MHz	90 µF/F		
	0.00006, 2 MHz	0.23 mF/F		
0.00009, 3 MHz	0.41 mF/F			
0.00014, 4 MHz	0.63 mF/F			
0.0002, 5 MHz	0.88 mF/F			
0.00057, 10 MHz	2.5. mF/F			
0.00083, 13 MHz	3.7 mF/F			
10 pF				
0.00002, 1 kHz	39 µF/F			
0.00002, 1 MHz	39 µF/F			
0.00002, 2 MHz	40 µF/F			
0.00002, 3 MHz	43 µF/F			
0.00002, 4 MHz	47 µF/F			
0.00003, 5 MHz	54 µF/F			
0.00007, 10 MHz	0.12 mF/F			
0.00009, 13 MHz	0.16 mF/F			

AH2500a Bridge,
HP8753C, 85046A,
4284A, 16074A,
16380C

Agilent/OEM
Procedures



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
Capacitance - Measure (cont.)	100 pF		AH2500a Bridge, HP8753C, 85046A, 4284A, 16074A, 16380C	Agilent/OEM Procedures
	0.00002, 1 kHz	38 µF/F		
	0.00002, 1 MHz	40 µF/F		
	0.00002., 2 MHz	48 µF/F		
	0.00003, 3 MHz	66 µF/F		
	0.00005, 4 MHz	91 µF/F		
	0.00006, 5 MHz	0.13 mF/F		
	0.00016, 10 MHz	0.33 mF/F		
	0.00024, 13 MHz	0.49 mF/F		
	1000 pF			
	0.00002, 1 kHz	41 µF/F		
	0.00003, 1 MHz	64 µF/F		
	0.00006, 2 MHz	0.15 mF/F		
	0.0001, 3 MHz	0.28 mF/F		
	0.00015, 4 MHz	0.44 mF/F		
	0.00021, 5 MHz	0.62 mF/F		
	0.00058 10 MHz	1.9 mF/F		
	0.00085 13 MHz	2.8 mF/F		
	0.01 µF			
	0.00002, 120 Hz	40 µF/F		
	1 kHz, 10 kHz			
	0.00002, 100 kHz	40 µF/F		
	0.1 µF			
	0.00003, 120 Hz	40 µF/F		
	0.00002, 1 kHz,	40 µF/F		
	10 kHz			
	0.00003, 100 kHz	40 µF/F		
	1 µF			
0.00004, 120 Hz	50 µF/F			
0.00002, 1 kHz	40 µF/F			
0.00003, 10 kHz	40 µF/F			
0.00004, 100 kHz	70 µF/F			
10 µF				
0.00004, 120 Hz	50 µF/F			
0.00003, 1 kHz	50 µF/F			
0.00028, 10 kHz	0.16 mF/F			
0.0007, 100 kHz	0.70 mF/F			

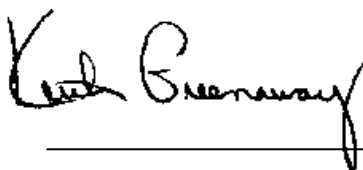
PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
HF Resistance - Measure	4 Terminal Pair 10 Ω 1 MHz 2 MHz 3 MHz 4 MHz 5 MHz 10 MHz 13 MHz 100 Ω 1 MHz 2 MHz 3,4,5 MHz 10 MHz 13 MHz 1 kΩ 100 kHz 1,2,3 MHz 4 MHz 5 MHz 10 MHz 13 MHz 10 kΩ 100 kHz 1 MHz 100 kΩ 100 kHz 1 MHz	0.3 mΩ/Ω 0.5 mΩ/Ω 0.6 mΩ/Ω 0.7 mΩ/Ω 1.0 mΩ/Ω 4.0 mΩ/Ω 6.0 mΩ/Ω 0.3 mΩ/Ω 0.3 mΩ/Ω 0.5 mΩ/Ω 2.0 mΩ/Ω 3.0 mΩ/Ω 0.3 mΩ/Ω 0.3 mΩ/Ω 0.4 mΩ/Ω 0.5 mΩ/Ω 2.0 mΩ/Ω 3.0 mΩ/Ω 0.2 mΩ/Ω 0.3 mΩ/Ω 0.3 mΩ/Ω 0.3 mΩ/Ω	HP 4285A, 16074A, 16380A	Agilent/OEM Procedures
HF Reactance - Measure	10 Ω 1 MHz 2,3 MHz 4 MHz 5 MHz 10 MHz 13 MHz 100 Ω 1,2,3,4,5 MHz 10 MHz 13 MHz	4 mΩ 5 mΩ 6 mΩ 7 mΩ 20 mΩ 40 mΩ 40 mΩ 80 mΩ 90 mΩ	HP 4285A, 16074A, 16380A	



PARAMETER / EQUIPMENT	RANGE	CALIBRATION & MEASUREMENT CAPABILITY [EXPRESSED AS UNCERTAINTY(±)]	REFERENCE STANDARD OR EQUIPMENT	METHOD(S)
HF Susceptance - Measure	1 kΩ 100 kHz 1,2,3,4,5 MHz 10,13 MHz	0.4 μS 0.4 μS 0.7 μS	HP 4285A, 16074A, 16380A	Agilent/OEM Procedures
	10 kΩ 100 kHz 1 MHz	0.04 μS 0.04 μS		
Frequency	10 MHz	1.33 x 10 ⁻⁹ Hz	58503 GPS Receiver (signal tracked and compared with NIST)	

Notes:

1. Calibration and Measurement Capabilities (CMC) (Expanded Uncertainties) are based on approximately a 95% confidence interval, using a coverage of k=2.
2. This scope is formatted as part of a single document including the Certificate of Accreditation No AC – 1813.



Vice-President